

Form PTO 1449 (Modified)		U.S. DEPARTMENT OF COMMERCE PATENT AND TRADEMARK OFFICE		ATTY DOCKET NO. 291453US0PCT		SERIAL NO. 10/580,003	
LIST OF REFERENCES CITED BY APPLICANT				APPLICANT Philippe KRAFFT, et al.		GROUP 1621	
				FILING DATE December 19, 2006			
U.S. PATENT DOCUMENTS							
EXAMINER INITIAL		DOCUMENT NUMBER	DATE	NAME	CLASS	SUB CLASS	FILING DATE IF APPROPRIATE
/RK/	AA	2,829,124	04-01-58	NAPRAVNIK et al.			
/RK/	AB	2,060,715	11-10-36	JAMES A. ARVIN			
/RK/	AC	2,319,876	05-25-43	WILLIAM HENRY MOSS			
/RK/	AD	2,444,333	06-29-48	PIERRE CASTAN			
	AC						
	AC						
	AC						
FOREIGN PATENT DOCUMENTS							
		DOCUMENT NUMBER	DATE	COUNTRY	TRANSLATION YES NO		
/RK/	AH	6-184024	07-05-94	JAPAN w/attached English Abstract			X
/RK/	AI	2001-213827	08-07-01	JAPAN (Corresponds to US 2001/0014763 – attached)			
/RK/	AJ	56-99432	08-10-81	JAPAN w/attached English Abstract			X
/RK/	AK	03-014527	01-23-91	JAPAN w/attached English Abstract			X
/RK/	AL	2001-1261581	09-26-01	JAPAN w/attached English Abstract			X
/RK/	AM	8-59593	03-05-96	JAPAN w/attached English Abstract (Corresponds to US 5,679,839 – attached)			
/RK/	AN	62-242638	10-23-87	JAPAN w/attached English Abstract			X
/RK/	AO	06-321852	11-22-94	JAPAN w/attached English Abstract			X
/RK/	AP	04-089440	03-23-92	JAPAN w/attached English Abstract			X
/RK/	AQ	56-29572	03-24-81	JAPAN (Corresponds to US 4,294,776)			
/RK/	AR	2003-89680	03-28-03	JAPAN (corresponds to EP 1 229 015 and US 6,521,794 – attached)			
/RK/	AS	2002-363153	12-18-02	JAPAN (corresponds to EP 1 273 570 and US 6,831,201 – attached)			
/RK/	AT	3-223267	10-02-91	JAPAN w/attached English Abstract			X
/RK/	AU	6-25196	04-06-94	JAPAN w/attached English Abstract			X
/RK/	AV	702,143	10-11-90	GREAT BRITAIN			
/RK/	AW	1,083,594	11-17-64	GREAT BRITAIN			
/RK/	AX	736,841	07-03-53	GREAT BRITAIN			
	AY						
	AZ						
	AAA						
OTHER REFERENCES (Including Author, Title, Date, Pertinent Pages, etc.)							
	AAB						
	AAC						<input type="checkbox"/> Additional References sheet(s) attached
Examiner		/Rosalynd Keys/				Date Considered 02/25/2010	
*Examiner: Initial if reference is considered, whether or not citation is in conformance with MPEP 609; Draw line through citation if not in conformance and not considered. Include copy of this form with next communication to applicant.							